

Search Notes

Application/Control No.

10/626,123

Examiner

Eduardo Colon Santana

Applicant(s)/Patent under
Reexamination

MAEKI, AKIRA

Art Unit

2837

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH plus TEXT SEARCH INCLUDING EPO, JPO and DERWERT DATABASES	2/28/2006	ECS
SEE ATTACHMENT FOR SEARCH HISTORY	2/28/2006	ECS